## Search Notes



Applicant(s)/Patent under Reexamination

Aр

/Yonel Beaulieu/

10/591,443 OYA ET AL.
Examiner Art Unit

3661

SEARCHED					
Class	Subclass	Date	Examiner		
701	41-44	12/2/2009	ΥB		
180	6.2				
	6.44				
	446				
475	19				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
Searched		12/2/2009	YB	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
WEST+Fwd/BWd	12/2/2009	YB	